

**Search Notes**

Application/Control No.

10/533,893

Examiner

Evan Dzierzynski

Applicant(s)/Patent under  
Reexamination

MASUDA, TAKESHI

Art Unit

2875

**SEARCHED**

Class	Subclass	Date	Examiner
362	617	7/20/2006	ED
	19	7/20/2006	ED
	615	7/20/2006	ED
	616	7/20/2006	ED
	600	7/20/2006	ED
362	617	2/26/2007	ED

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Search advice from Ali Alavi	7/20/2006	ED
EAST word search, attached	7/20/2006	ED
EAST word search, updated & attached	2/26/2007	ED